## Application/Control No. Applicant(s)/Patent Under Reexamination 09/655,231 YANO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Jamie Vent 2616 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,324,338 11-2001 Wood et al. 386/83 Α 10-2003 386/83 US-6,636,688 Otana, Hiroshi В US-6,642,939 11-2003 Vallone et al. 715/721 С 06-1994 360/15 Stebbings et al. US-5,325,238 D 07-2000 Sawada, Yoshiaki 710/38 US-6,085,262 Ε 725/46 F US-6,581,207 06-2003 Sumita et al. US-G Н US-US-US-J US-K

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